

**Search Notes**

Application/Control No.

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Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

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Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	3/7/2007	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
see interference search		3/7/2007	DH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR